

Search Notes

Application/Control No.

09/823,396

Examiner

Annan Q. Shang

Applicant(s)/Patent under
Reexamination

TAGUCHI ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
725	44-49	2/5/2005	A.S
725	53,60,61	2/5/2005	A.S

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR